What is claimed is:

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- A differential amplifier circuit comprising a latch unit and a differential input portion, wherein a minute current is kept to flow through said differential input portion.
- The different/al amplifier circuit as claimed in claim 1, wherein:

said differential input portion comprises a first transistor and a second transistor each having a first electrode, a second electrode and a control electrode;

Me control electrodes of said first and second transistors are supplied with a differential input signal; and

a third transistor for keeping a minute current to flow through said first and second transistors is inserted between a first power line and a common node to which the first electrodes of said first and second transistors are connected.

- The differential amplifier circuit as claimed in claim 2, wherein said third transistor turns off said minute current flowing through said first and second transistors upon deactivation of said differential amplifier circuit.
- The differential amplifier circuit as claimed in claim 2, wherein:

a fourth transistor for supplying a drive current at the time of signal determination in said differential amplifuer circuit is inserted between said first power line and the common node to which the first electrodes of said first and second transistors are connected; and

said third transistor is connected in parallel to safid fourth transistor.

The differential amplifier circuit as claimed 5. in claim 4, wherein the control electrode of said third transistor #s supplied with a first control signal for

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constantly supplying a minute current during the operation of said differential amplifier.

- 6. The differential amplifier circuit as claimed in claim 4, wherein a gate width of said third transistor is smaller than a gate width of said fourth transistor.
- 7. The differential amplifier circuit as claimed in claim 2 wherein said third transistor doubles as a transistor for supplying a drive current at the time of signal determination by said differential amplifier circuit.
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- 8. The differential amplifier circuit as claimed in claim 7, wherein the first control signal supplied to the control electrode of said third transistor is set to a level for supplying a predetermined drive current at the time of signal determination in said differential amplifier circuit, while causing a minute current to flow through said first and second transistors at other than the time of signal determination during the operation of said differential amplifier.
- 9. The differential amplifier circuit as claimed in claim 1, wherein said latch unit comprises:

a first inverter inserted between the second electrode of said first transistor and a second power line; and

a second inverter inserted between the second electrode of said second transistor and said second power line, said first and second inverters being cross-coupled to each other.

10. The differential amplifier circuit as claimed in claim 9, wherein:

said differential amplifier circuit is configured of MOS transistors;

transistors of said first and second inverters which are connected to said second power line are each connected in parallel to an additional transistor, respectively; and

the second electrode of each of said first

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and second transistors is held at a predetermined level at other than the time of signal determination during the operation of said differential amplifier.

The differential amplifier circuit as claimed in claim 1, further comprising:

a fifth transistor connected to the second electrode of said first transistor and the second electrode of said second electrode for shorting the second electrodes of said first and second transistors in accordance with a second control signal.

12. The differential amplifier circuit as claimed in claim 1, further comprising:

a sixth transistor connected to the second electrode of said first transistor and the second electrode of said second transistor, said sixth transistor having a control electrode supplied with a predetermined voltage.

13. The differential amplifier circuit as claimed in claim 12, wherein said differential input signal is at CML level.

14. The differential amplifier circuit as claimed in claim 1, further comprising:

a seventh transistor inserted between two nodes for retrieving a differential output signal, said seventh transistor shorting said two nodes in accordance with a third control signal.

15. The differential amplifier circuit as claimed in claim 1, further comprising:

an eighth transistor inserted between said second power line and the common node to which the first electrodes of said first and second transistors are connected, the control electrode of said eighth transistor being supplied with a fourth control signal.

The differential amplifier circuit as claimed in claim 1, wherein said differential amplifier circuit is a differential sense amplifier circuit of strong arm latch type.

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Sulte Sulte 17. A semiconductor integrated circuit device having a differential amplifier circuit receiving a differential signal, a latch circuit latching an output signal of said differential amplifier circuit, and a clock source generating a clock and supplying the generated clock to said differential amplifier circuit, wherein said differential amplifier circuit comprises a latch unit and a differential input portion, wherein a minute current is kept to flow through said differential input portion.

18. The semiconductor integrated chrcuit device as

claimed in claim 17, wherein said semiconductor

comprising a transmission circuit outputting the

through said signal transmission path.

receiving circuit receiving the differential signal

integrated circuit is a receiving circuit of a signal transmission system, said signal transmission system

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19. The semiconductor integrated circuit device as claimed in claim 18, further comprising:

differential signal, a signal transmission path, and said

an equalizer circuit, receiving the differential signal, removing an Inter-Symbol Interference of the differential signal by a Partial Response Detection, and outputting the Inter-Symbol Interference removed differential signal to said differential amplifier circuit.

- 20. The semiconductor integrated circuit device as claimed in claim 19 comprising a plurality of receiving units each including said differential amplifier circuit, said latch circuit and said equalizer circuit, said plurality of receiving units carrying out an interleave operation.
- 21. The semiconductor integrated circuit device as claimed in claim 17, wherein:

said differential input portion comprises a first transistor and a second transistor each having a first electrode, a second electrode and a control

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electrode;

the control electrodes of said first and second transistors are supplied with the differential input signal; and

a third transistor for keeping a minute current to flow through said first and second transistors is inserted between a first power line and a common node to which the first electrodes of said first and second transistors are connected.

22. The semiconductor integrated circuit device as claimed in claim 21, wherein said third transistor turns off said minute current flowing through said first and second transistors upon deactivation of said differential amplifier circuit.

23. The semiconductor integrated circuit device as claimed in claim 21, wherein:

a fourth transistor for supplying a drive current at the time of signal determination in said differential amplifier circuit is inserted between said first power line and the common node to which the first electrodes of said first and second transistors are connected; and

said third transistor is connected in parallel to said fourth transistor.

24. The semiconductor integrated circuit device as claimed in claim 23, wherein the control electrode of said third transistor is supplied with a first control signal for constantly supplying a minute current during the operation of said differential amplifier.

25. The semiconductor integrated circuit device as claimed in claim 23, wherein a gate width of said third transistor is smaller than a gate width of said fourth transistor.

26. The semiconductor integrated circuit device as claimed in claim 21 wherein said third transistor doubles as a transistor for supplying a drive current at the time of signal determination by said differential

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amplif circuit.

The semiconductor integrated circuit device as claimed in claim 26, wherein the first control signal supplied to the control electrode of said third transistor is set/to a level for supplying a predetermined drive current at the time of signal determination An said differential amplifier circuit, while causing a minute current to flow through said first and second/transistors at other than the time of signal determination during the operation of said differential amplifier.

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The semiconductor integrated circuit device as 28. claimed in claim 17, wherein said latch unit comprises:

a first inverter inserted between the second electrode of said first transistor and a second

power line; and

a second inverter inserted between the second electrode of said second transistor and said second power line, said first and second inverters being cross-coupled to each other.

The semiconductor integrated circuit device as claimed in claim 28, wherein:

said differential amplifier circuit is configured of MOS transistors;

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transfistors of said first and second inverters which are connected to said second power line are each connected in parallel to an additional transistor, respectively; and

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the second electrode of each of said first and second transistors is held at a predetermined level at other than the time of signal determination during the operation of said differential amplifier.

The semiconductor integrated circuit device as claimed in claim 17, wherein said differential amplifier circuit further comprising:

fifth transistor connected to the second electrode of said first transistor and the second

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electrode of said second electrode for shorting the second electrodes of said first and second transistors in accordance with a second control signal.

31. The semiconductor integrated circuit device as claimed in claim 17, wherein said differential amplifier circuit further comprising:

a sixth transistor connected to the second electrode of said first transistor and the second electrode of said second transistor, said sixth transistor having a control electrode supplied with a predetermined voltage.

- 32. The semiconductor integrated circuit device as claimed in claim 31, wherein said differential input signal is at CML level.
- 33. The semiconductor integrated circuit device as claimed in claim 17, wherein said differential amplifier circuit further comprising:

a seventh transistor inserted between two nodes for retrieving a differential output signal, said seventh transistor shorting said two nodes in accordance with a third control signal.

34. The semiconductor integrated circuit device as claimed in claim 17, wherein said differential amplifier circuit further comprising:

an eighth transistor inserted between said second power line and the common node to which the first electrodes of said first and second transistors are connected, the control electrode of said eighth transistor being supplied with a fourth control signal.

35. The semiconductor integrated circuit device as claimed in claim 17, wherein said differential amplifier circuit is a differential sense amplifier circuit of strong arm latch type.

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